

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/695,478	IDOTA ET AL.
	Examiner	Art Unit
	Anh D. Mai	2814

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (all) • Inventors • CCLS • bipolar transistor and lateral and (etch mask) • SiGe HBT	3/15/2005	A.M
IEEE explore (web): HBT and SiGe	3/15/2005	A.M
JPO (web): Fi/F term 5F003; 5F082	3/15/2005	A.M

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
438	235; 309 312	3/15/05	A.M